

<b>Notice of References Cited</b>	Application/Control No. 10/594,784	Applicant(s)/Patent Under Reexamination ONO ET AL.	
	Examiner Karuna P. Reddy	Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,989,665 A	11-1976	Hollingshead, William S.	524/349
*	B	US-6,156,849 A	12-2000	Moriyama et al.	525/329.5
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 61171737 A	08-1986	Japan	HIRAMATSU et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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